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MOSFET - Power, Single N-Channel, µ8FL

100 V, 30 mΩ, 35 A

NTTFS030N10G

Features

- Wide SOA for Linear Mode Operation
- Low R_{DS(on)} to Minimize Conduction Losses
- High Peak UIS Current Capability for Ruggedness
- Small Footprint (3.3 x 3.3 mm) for Compact Design
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

• 48 V Hot Swap System, Load Switch, Soft-Start, E-Fuse

MAXIMUM RATINGS (T_{.1} = 25°C unless otherwise noted)

| | | | , | | 1 |
|-----------------------------------------------------------------------------------------|---------------------|----------------------------|-----------------------------------|----------------|-----|
| Parar | Symbol | Value | Unit | | |
| Drain-to-Source Voltage | | | V _{DSS} | 100 | V |
| Gate-to-Source Voltage | V _{GS} | ±20 | V | | |
| Continuous Drain | | $T_{C} = 25^{\circ}C$ | ۱ _D | 35 | А |
| Current R _{θJC} (Note 2) | Steady State | T _C = 100°C | | 24 | |
| Power Dissipation | | $T_{C} = 25^{\circ}C$ | PD | 74 | W |
| R _{θJC} (Note 2) | | T _C = 100°C | | 37 | |
| Continuous Drain | | T _A = 25°C | Ι _D | 6 | А |
| Current R _{θJA} (Notes 1, 2) | Steady State | T _A = 100°C | | 4 | |
| Power Dissipation | | State | T _A = 25°C | PD | 2.5 |
| R _{θJA} (Notes 1, 2) | | T _A = 100°C | | 1.2 | |
| Pulsed Drain Current | T _A = 25 | °C, t _p = 10 μs | I _{DM} | 306 | А |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | –55 to +175 | °C |
| Source Current (Body Diode) | | | I _S | 61 | А |
| Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)}$ = 13 A, L = 1 mH) | | | E _{AS} | 84 | mJ |
| Lead Temperature Soldering Reflow for Sol- dering Purposes (1/8" from case for 10 s) | | | ΤL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

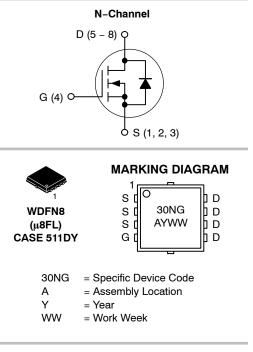
 Surface-mounted on FR4 board using a 1 in², 1 oz. Cu pad.
The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



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| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX | | |
|----------------------|---------------------------------------|--------------------|--|--|
| 100 V | $30~\mathrm{m}\Omega @ 10~\mathrm{V}$ | 35 A | | |



ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Value | Unit |
|---------------------------------------------|-----------------------|-------|------|
| Junction-to-Case - Steady State (Note 2) | $R_{	extsf{	heta}JC}$ | 2.0 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 60 | |

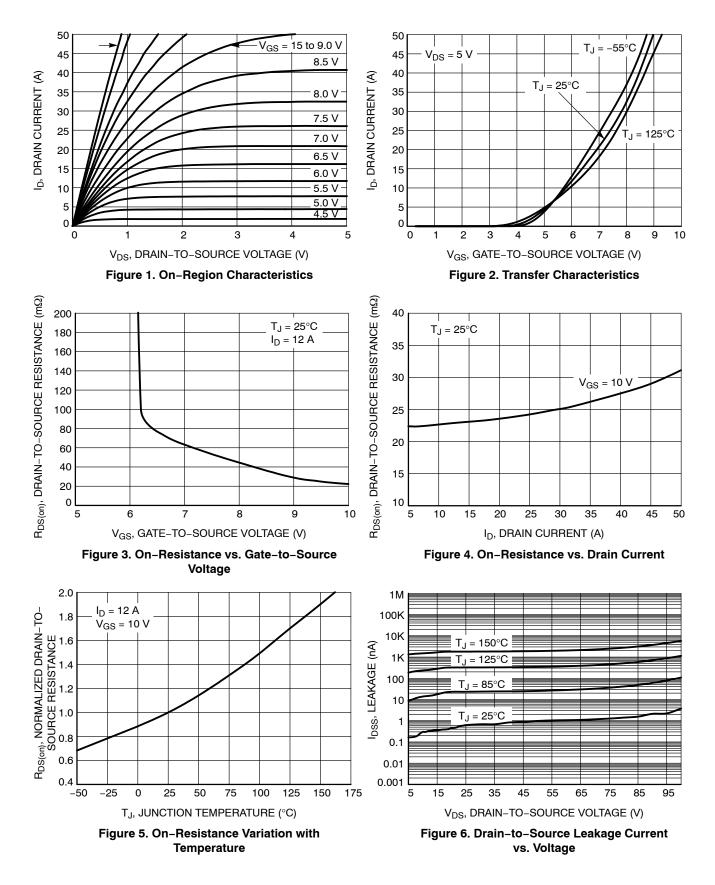
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--------------------------------------------------------------|-----------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------|-----|------|------|-------|
| OFF CHARACTERISTICS | | | | | • | - | - |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I _D = 250 μ A | | 100 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | $I_D = 250 \ \mu$ A, referenced to 25°C | | | 90.8 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, T _J = 25°C | | | | 1 | μA |
| | | $V_{\rm DS} = 80 \text{ V}$ T _J = 150°C | T _J = 150°C | | | 100 | - |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _G | _S = ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 3) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_{D}$ | = 61 μA | 2.0 | | 4.0 | V |
| Negative Treshold Temperature Coefficient | V _{GS(TH)} /T _J | I _D = 61 μA, refere | $I_D = 61 \ \mu$ A, referenced to 25°C | | -9.5 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, I | _D = 12 A | | 23 | 30 | mΩ |
| Forward Transconductance | 9 _{FS} | $V_{DS} = 5 V, I_D = 12 A$ | | | 3.8 | | S |
| Gate-Resistance | R _G | T _A = 25°C | | | 0.7 | | Ω |
| CHARGES AND CAPACITANCES | | | | | | | |
| Input Capacitance | C _{iss} | V_{GS} = 0 V, f = 1 MHz, V_{DS} = 50 V | | | 1366 | | pF |
| Output Capacitance | C _{oss} | | | | 161 | | - |
| Reverse Transfer Capacitance | C _{rss} | | | | 21.5 | | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 50 \text{ V}, \text{ I}_{D} = 12 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 50 \text{ V}$ | | | 21.5 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 4 | | - |
| Gate-to-Source Charge | Q _{GS} | | | | 8.4 | | |
| Gate-to-Drain Charge | Q _{GD} | | | | 4.7 | | |
| Output Charge | Q _{OSS} | | | | 15.6 | | |
| SWITCHING CHARACTERISTICS (No | ote 4) | | | | | | |
| Turn-On Delay Time | t _{d(on)} | | | | 13.4 | | ns |
| Rise Time | t _r | V _{CS} = 10 V. V _D | s = 50 V. | | 5.1 | | 1 |
| Turn-Off Delay Time | t _{d(off)} | V_{GS} = 10 V, V_{DS} = 50 V, I_{D} = 12 A, R_{G} = 4.7 Ω | | | 19 | | |
| Fall Time | t _f | | | | 4.3 | | |
| DRAIN-SOURCE DIODE CHARACTER | RISTICS | | | | • | | |
| Forward Diode Voltage | V_{SD} $V_{GS} = 0 V$, $T_J = 25^{\circ}C$ | | 0.84 | 1.2 | V | | |
| | | $I_{\rm S} = 12 \rm{A}$ | T _J = 125°C | | 0.71 | | 1 |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, dl _S /dt = 300 A/μs, I _S = 6 A | | | 25.7 | | ns |
| Reverse Recovery Charge | Q _{RR} | | | | 80.8 | | nC |
| Reverse Recovery Time | t _{RR} | $\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \ dI_S/dt = 1000 \ A/\mu s, \\ I_S = 6 \ A \end{array}$ | | | 22.2 | | ns |
| Reverse Recovery Charge | Q _{RR} | | | | 156 | | nC |

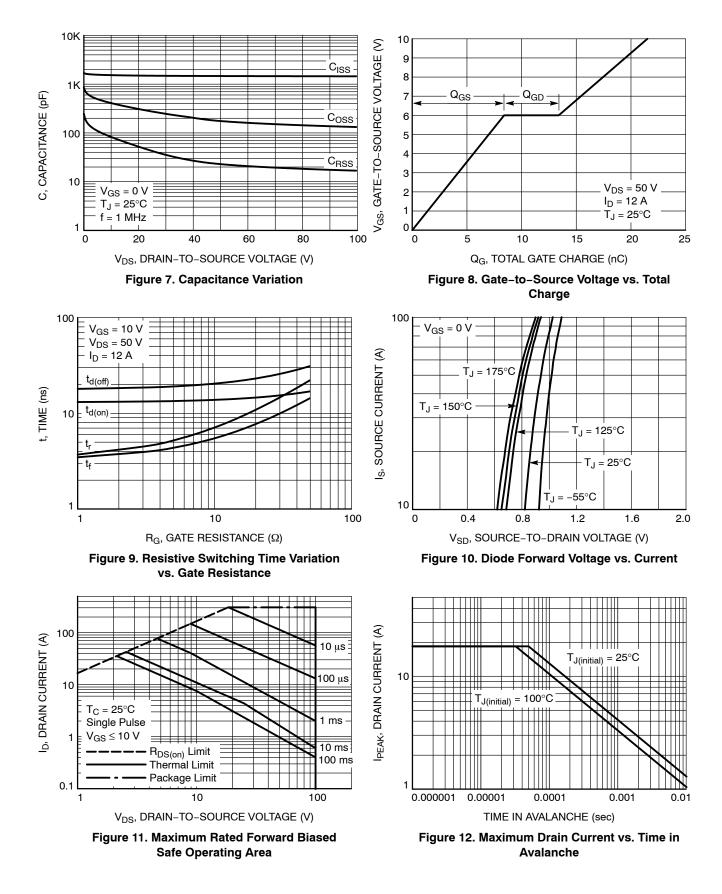
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

4. Switching characteristics are independent of operating junction temperatures.

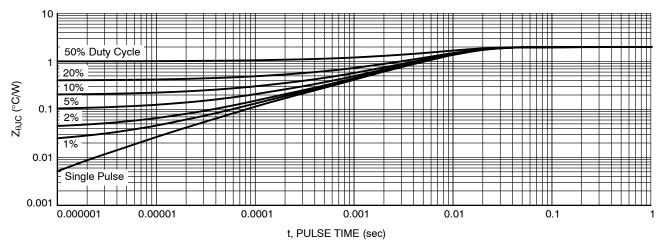
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



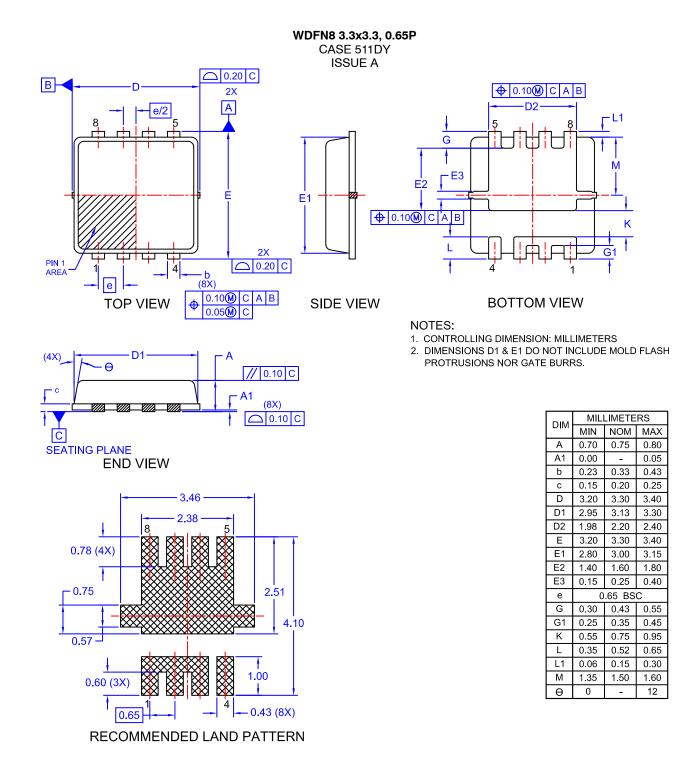


DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|--------------|---------|-------------------|-----------------------|
| NTTFS030N10G | 30NG | μ8FL (Pb–Free) | 1500 / Tape & Reel |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



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